



# EMC TEST REPORT

Product Name: Bluetooth Headphones

Model Name: HS-BN928

Issued For : Honsenn Technology Co.Ltd

No.70, Erheng Road, wentang zhuangyao industrial zone,  
Dongcheng district,Dongguan City,Guangdong Province.

Issued By : Shenzhen LGT Test Service Co., Ltd.

Room 205, Building 13, Zone B, Chen Hsong Industrial Park,  
No.177 Renmin West Road, Jinsha Community, Kengzi Street,  
Pingshan New District, Shenzhen, China

Report Number: LGT23D025EM01

Sample Received Date: Apr. 10, 2023

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Date of Issue: Apr. 20, 2023



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**Revision History**

Rev.	Issue Date	Revisions
00	Apr. 20, 2023	Initial Issue



## TEST REPORT CERTIFICATION

**Applicant:** Honsenn Technology Co.Ltd  
**Address:** No.70, Erheng Road, wentang zhuangyao industrial zone, Dongcheng district, Dongguan City, Guangdong Province.

**Manufacture:** Honsenn Technology Co.Ltd  
**Address:** No.70, Erheng Road, wentang zhuangyao industrial zone, Dongcheng district, Dongguan City, Guangdong Province.

**Factory:** Honsenn Technology Co.Ltd  
**Address:** No.70, Erheng Road, wentang zhuangyao industrial zone, Dongcheng district, Dongguan City, Guangdong Province.

**Product Name:** Bluetooth Headphones

**Trademark:** N/A

**Model Name:** HS-BN928

**Sample Status:** Normal

APPLICABLE STANDARDS	
STANDARD	TEST RESULTS
ETSI EN 301 489-1 V2.2.3 (2019-11) ETSI EN 301 489-17 V3.2.4 (2020-09)	PASS

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Technical Director



- (1) The test report is effective only with both signature and specialized stamp.
- (2) This report shall not be reproduced except in full without the written approval of the Laboratory.
- (3) The results in this report apply to the test sample(s) mentioned above at the time of the testing period only and are not to be used to indicate applicability to other similar products.



## 1. TEST SUMMARY

Test procedures according to the technical standards:

ETSI EN 301 489-1 V2.2.3 (2019-11)

ETSI EN 301 489-17 V3.2.4 (2020-09)

EMC Emission				
Standard	Test Item	Limit	Judgement	Remark
EN 55032:2015/A11:2020	Conducted Emission on AC And Telecom Port 150kHz to 30MHz	Class B	N/A	NOTE (4)
	Radiated Emission 30MHz to 1000MHz	Class B	PASS	
	Radiated Emission 1GHz to 6GHz	Class B	PASS	NOTE (1)
EN IEC 61000-3-2:2019	Harmonic Current Emission	Class A	N/A	NOTE (4)
EN 61000-3-3:2013+A1:2019	Voltage Fluctuations & Flicker	-----	N/A	NOTE (4)
EMC Immunity				
Section	Test Item	Performance Criteria	Judgement	Remark
EN 61000-4-2:2009	Electrostatic discharges	B	PASS	
EN IEC 61000-4-3:2020	Continuous RF electromagnetic field disturbances	A	PASS	
EN 61000-4-4:2012	Electrical fast transients/burst	B	N/A	NOTE (4)
EN 61000-4-5:2014/A1:2017	Surges	B	N/A	NOTE (4)
EN 61000-4-6:2014+AC:2015	Continuous induced RF disturbances	A	N/A	NOTE (4)
EN IEC 61000-4-11:2020	Voltage dips and interruptions	B / B / C / C	N/A	NOTE (4)

Note:

- (1) If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz.  
If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.  
If the highest frequency of the internal sources of the EUT is between 500 MHz and 1GHz, the measurement shall only be made up to 5 GHz.  
If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times of the highest frequency or 6 GHz, whichever is less.
- (2) The power consumption of EUT is less than 75W and no Limits apply.
- (3) Voltage Dip: 100% reduction – Performance Criteria B  
Voltage Dip: 70% reduction – Performance Criteria C  
Voltage Interruption: 100% Interruption – Performance Criteria C
- (4) EUT cannot be charged when it is powered on. Therefore, the test of AC power supply is not evaluated.



## 1.1 TEST FACTORY

Company Name:	Shenzhen LGT Test Service Co., Ltd.
Address:	Room 205, Building 13, Zone B, Chen Hsong Industrial Park, No.177 Renmin West Road, Jinsha Community, Kengzi Street, Pingshan New District, Shenzhen, China
Accreditation Certificate	A2LA Certificate No.: 6727.01
	FCC Registration No.: 746540
	CAB ID: CN0136

## 1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement  $y \pm U$ , where expanded uncertainty  $U$  is based on a standard uncertainty multiplied by a coverage factor of  $k=2$ , providing a level of confidence of approximately **95** %.

Test Item	Measurement Frequency Range	Uncertainty
Conducted Emissions	0.009MHz ~ 0.15MHz	3.18
Conducted Emissions	0.15MHz ~ 30MHz	2.70
Radiated Emissions	9KHz ~ 30MHz	2.50
Radiated Emissions	30MHz ~ 1000MHz	4.40
Radiated Emissions	1GHz ~ 6 GHz	5.10
Radiated Emissions	6GHz ~ 18GHz	5.49

Note: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ .



## 2. GENERAL INFORMATION

### 2.1 GENERAL DESCRIPTION OF THE EUT

Product Name:	Bluetooth Headphones
Trademark:	N/A
Model Name:	HS-BN928
Series Model:	N/A
Model Difference:	N/A
Maximum Operating Frequency:	2480MHz
Frequency Bands:	Bluetooth: 2402-2480MHz
Modulation Mode:	Bluetooth: GFSK, $\pi/4$ -DQPSK, 8DPSK
Rating:	Input: DC 5V, 1A
Battery:	Capacity: 900mAh Rated Voltage: 3.7V
Hardware Version:	V1.3
Software Version:	V2.0



## 2.2 DESCRIPTION OF THE TEST MODES

To investigate the maximum EMI emission characteristics generated from EUT, the test system was pre-scanned based on the consideration of following EUT operation mode or test configuration mode which possibly have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Test Mode	Description
Mode 1	Bluetooth

## 2.3 DESCRIPTION OF THE SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

### Accessories Equipment

Description	Manufacturer	Model	S/N	Rating

### Auxiliary Equipment

Description	Manufacturer	Model	S/N	Rating
Adapter	Tenpao	S005CAU05001 00	N/A	Input: 100-240V ~ 50/60Hz 0.2A Output: 5V, 1A
USB-A to USB-C Cable	UGREEN	US287	N/A	1m, shielded, without ferrite core
Mobile phone	SHARK	KSR-10	N/A	N/A
3.5mm to 3.5mm Cable	N/A	N/A	N/A	0.5m

Note:

- (1) For detachable type I/O cable should be specified the length in cm in 『Length』 column.
- (2) “YES” means “with core”; “NO” means “without core”.





## 2.4 MEASUREMENT INSTRUMENTS LIST

<b>Conducted Emission</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
EMI Test Receiver	R&S	ESU8	100372	2023.04.10	2024.04.09
LISN	COM-POWER	LI-115	02032	2023.04.10	2024.04.09
LISN	SCHWARZBECK	NNLK 8121	00847	2022.08.19	2023.08.18
ISN	FCC	T4-02	91317	2022.06.08	2023.06.07
ISN	SCHWARZBECK	NTFM 8158	00303	2022.08.19	2023.08.18
Transient Limiter	CYBERTEK	EM5010A	E2250100049	2022.08.19	2023.08.18
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
Testing Software	EMC-I_V1.4.0.3_SKET				
<b>Radiated Emission</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
EMI Test Receiver	R&S	ESU8	100372	2023.04.10	2024.04.09
Spectrum Analyzer	Keysight	N9020A	MY50530994	2022.12.09	2023.12.08
Spectrum Analyzer	Keysight	N9010B	MY60242508	2022.04.29	2023.04.28
Active loop Antenna	ETS	6502	00049544	2022.06.02	2024.06.01
Bilog Antenna	SCHAFFNER	CBL6112B	2705	2022.06.05	2024.06.04
Bilog Antenna	SCHWARZBECK	VULB 9168	01447	2022.12.12	2023.12.11
Horn Antenna	SCHWARZBECK	3115	10SL0060	2022.06.02	2024.06.01
Pre-amplifier (9kHz-1GHz)	EMtrace	RP01A	02017	2023.04.10	2024.04.09
Pre-amplifier (1-26.5G)	Agilent	8449B	3008A4722	2023.04.10	2024.04.09
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
Testing Software	EMC-I_V1.4.0.3_SKET				
<b>Harmonic &amp; Flick</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Harmonic Voltage & Flicker	AMETEK	100-CTS-230	2229A00121	2022.12.09	2023.12.08
AC Power Source	AMETEK	3001iX-208-413	2236A00794	2022.12.09	2023.12.08
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
<b>Electrostatic Discharge (ESD)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
ESD TEST GENERATOR	EMTEST	ESD-30N	V1051108174	2022.08.22	2023.08.21
Temperature & Humidity	SuWei	ST-W2318	N.A	2022.05.05	2023.05.04
<b>Radio Frequency Electromagnetic Fields (RS)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Power Sensor	R&S	Z11	116655	2022.12.09	2023.12.08
Power Sensor	R&S	Z11	121896	2022.12.09	2023.12.08
Signal Generator	Agilent	N5181A	MY47070409	2022.12.09	2023.12.08
Power Amplifier	SKET	HAP_80M01G-250W	S202211402	2022.12.09	2023.12.08
Power Amplifier	SKET	HAP_010G060G-80W	S202211403	2022.12.09	2023.12.08
RS Test Antenna	SKET	STLP 9129 Plus	SK20221012006	N.A	N.A
<b>Radio Frequency Continuous Conducted (CS)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Conducted Radio-frequency	PRIMA	CRF61006A	PR211281052	2022.04.29	2023.04.28



Test System					
CDN	PRIMA	CRF-CDN-M2 16	PR220281070	2022.04.29	2023.04.28
CDN	PRIMA	CRF-CDN-M3 16	PR220281074	2022.04.29	2023.04.28
Attenuator	PRIMA	ATT-6DB-100	W2198770001	2022.04.29	2023.04.28
Electromagnetic Injection Clamp	ZHINAN	ZN23203	PR211281055	2022.04.29	2023.04.28
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
<b>Fast Transients Common Mode (EFT)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Fast Transient Burst Simulator	PRIMA	EFT61004TA	PR220243451	2022.04.29	2023.04.28
EFT CAPACITIVE COUPLING CLAMP	PRIMA	EFT-CLAMP	457	2022.04.29	2023.04.28
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
<b>Surge</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Lightning Surge Generator (1.2us.50us)	PRIMA	SUG61005TA X	PR211155290	2022.04.29	2023.04.28
Lightning Surge Generator (10us.700us)	PRIMA	SUG10/700TA	PR211255516	2022.04.29	2023.04.28
Signal line decoupling network	PRIMA	DATA-CDN-8 B	PR211255479	2022.12.26	2023.12.25
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
<b>Voltage Dips and Interruptions</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Cycle Sag Simulator	PRIMA	DRP61011TA	PR21126644	2022.04.29	2023.04.28
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04
<b>PFMF</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Serial No.</b>	<b>Cal. Date</b>	<b>Cal. Until</b>
Power Frequency Magnetic Field Generator	PRIMA	PFM61008TG	PR211281444	2022.04.29	2023.04.28
Temperature & Humidity	KTJ	TA218B	N.A	2022.05.05	2023.05.04



### 3. EMC EMISSION TEST

#### 3.1 CONDUCTED EMISSION MEASUREMENT

##### 3.1.1 POWER LINE CONDUCTED EMISSION

(Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	79.00	66.00	66 - 56 *	56 - 46 *
0.5 ~ 5	73.00	60.00	56.00	46.00
5 ~ 30	73.00	60.00	60.00	50.00

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " \* " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

Telecommunications/network Port

FREQUENCY (MHz)	Voltage limits Class A(dBuV)		Current limits Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	84 to 74	74 to 64	40 to 30	30 to 20
0.5 ~ 30	74	64	30	20

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network.

(ISN) which presents a common mode (asymmetric mode) impedance of 150 Ω to the telecommunication port under test (conversion factor is  $20 \log_{10} 150 / 1 = 44$  dB).

The following table is the setting of the receiver

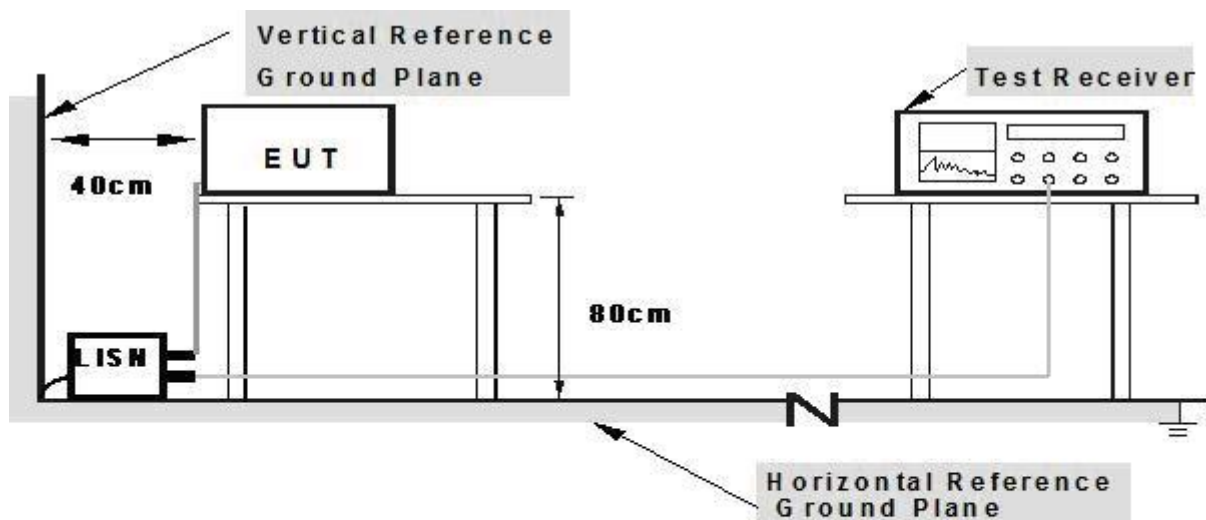
Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz



### 3.1.2 TEST PROCEDURE

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. For the actual test configuration, please refer to the related Item –EUT Test Photos.

### 3.1.3 TEST SETUP



- Note: 1. Support units were connected to second LISN.**  
**2. Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes**

### 3.1.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 described unless otherwise a special operating condition is specified in the following during the testing.

### 3.1.5 TEST RESULTS

N/A



### 3.2 RADIATED EMISSION MEASUREMENT

#### 3.2.1 LIMITS OF THE RADIATED EMISSION MEASUREMENT (Below 1000MHz)

FREQUENCY (MHz)	Class A		Class B	
	At 10m	At 3m	At 10m	At 3m
	dBuV/m	dBuV/m	dBuV/m	dBuV/m
30 ~ 230	40	50	30	40
230 ~ 1000	47	57	37	47

#### 3.2.2 LIMITS OF THE RADIATED EMISSION MEASUREMENT (Above 1000MHz)

FREQUENCY (MHz)	Class A (at 3m) dBuV/m		Class B (at 3m) dBuV/m	
	Peak	AVG	Peak	AVG
1000 ~ 3000	76	56	70	50
3000 ~ 6000	80	60	74	54

Notes:

- (1) The limit for radiated test was performed in the following: CISPR 32.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBuV/m) = 20log Emission level (uV/m).

#### 3.2.3 TEST PROCEDURE

- a. The EUT was placed on the top of a rotating table 0.8 meter above the ground at a 3 meter semi-anechoic chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. EUT as the center to the edge of the auxiliary device, the distance from the maximum edge to the center of the antenna is 3 meter.
- c. The height of antenna is varied from 1 meter to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meter and the rotatable table was turned from 0 degrees to 360 degree to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1GHz.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

### 3.2.4 TEST SETUP

#### (A) Radiated Emission Test Setup Frequency Below 1 GHz

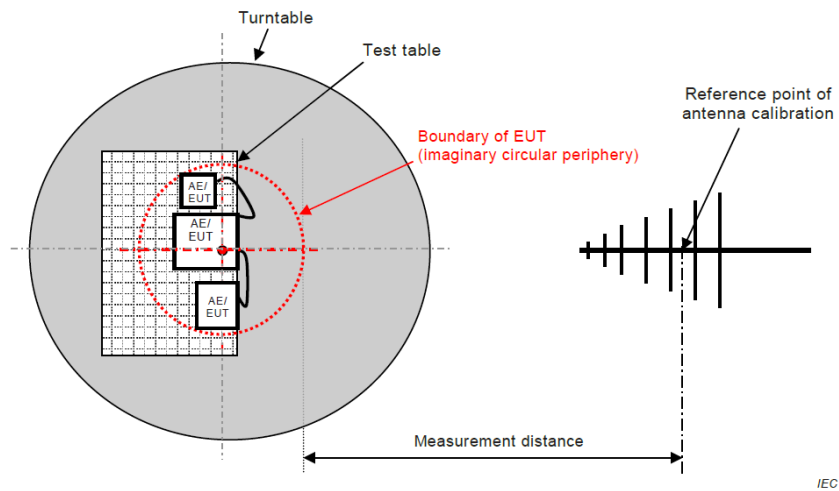


Figure C.1 – Measurement distance

#### (B) Radiated Emission Test Setup Frequency Above 1GHz

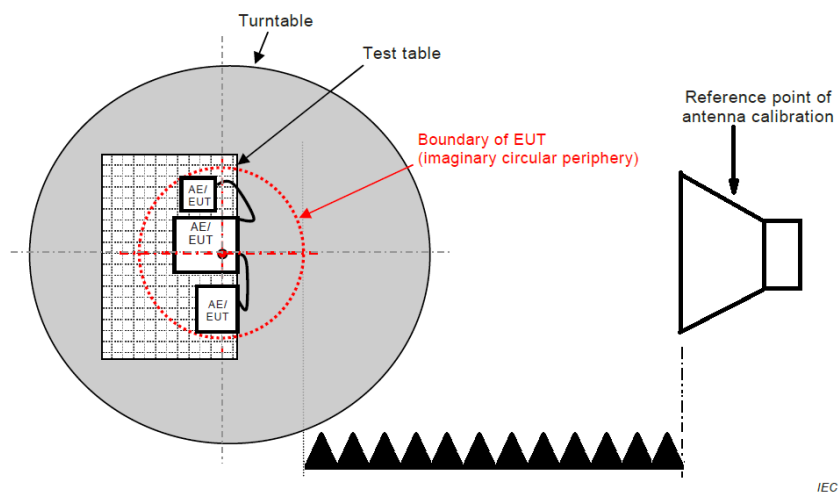


Figure C.1 – Measurement distance

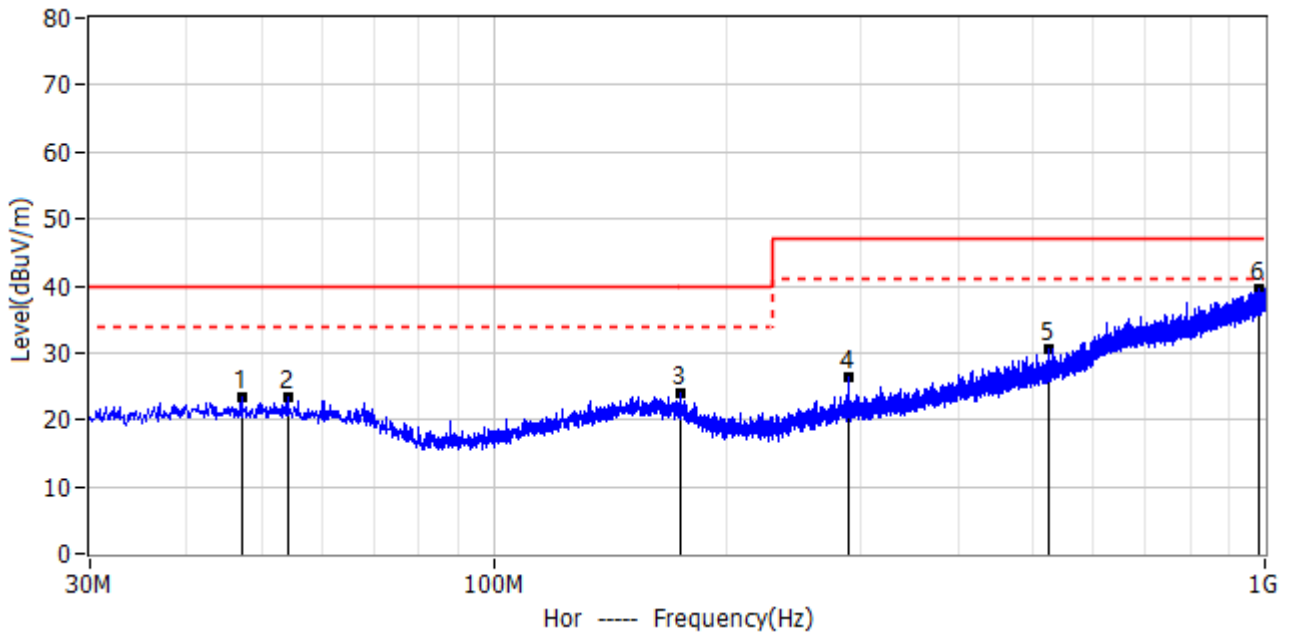
### 3.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 described unless otherwise a special operating condition is specified in the following during the testing.



### 3.2.6 TEST RESULTS (30 - 1000 MHz)

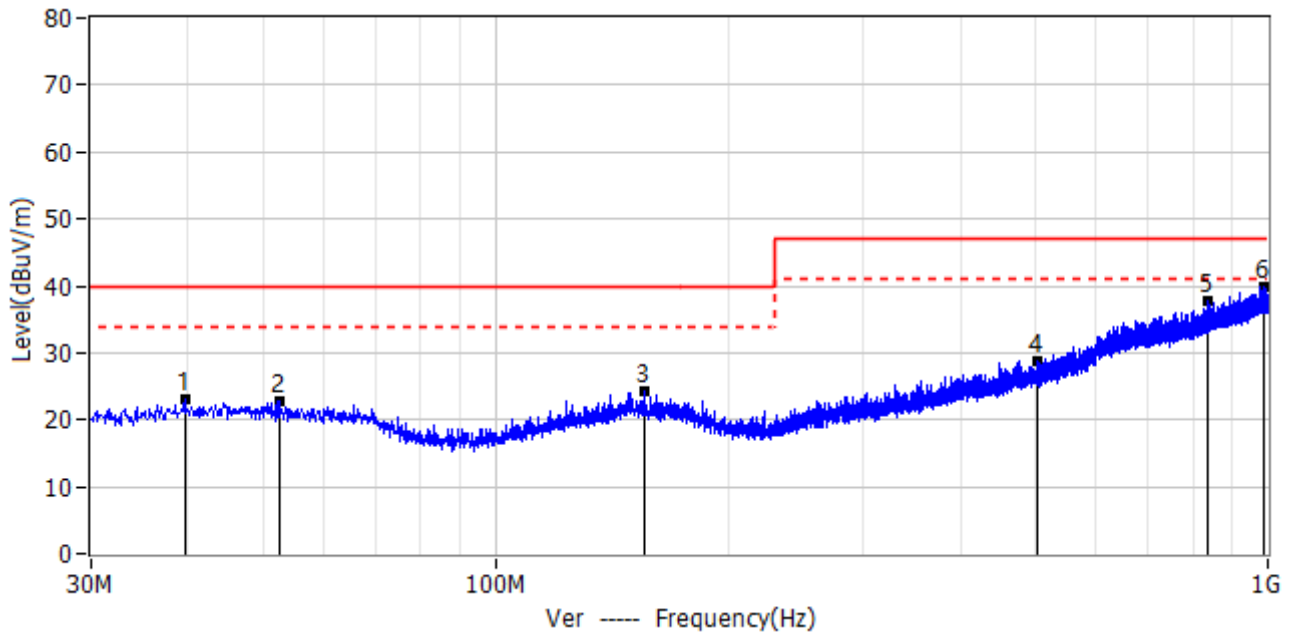
Project: LGT23D025	Test Engineer: Dylan.shi
EUT: Bluetooth Headphones	Temperature: 28.3°C
M/N: HS-BN928	Humidity: 55%RH
Test Voltage: Battery	Test Data: 2023-04-12
Test Mode: Bluetooth	
Note:	



No.	Frequency	Reading dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Margin dB	Detector	Polar
1*	47.218MHz	4.03	19.28	23.31	40.00	-16.69	QP	Hor
2*	54.129MHz	4.20	19.06	23.26	40.00	-16.74	QP	Hor
3*	175.015MHz	4.55	19.31	23.86	40.00	-16.14	QP	Hor
4*	287.899MHz	6.76	19.67	26.43	47.00	-20.57	QP	Hor
5*	524.700MHz	4.97	25.51	30.48	47.00	-16.52	QP	Hor
6*	982.055MHz	5.17	34.49	39.66	47.00	-7.34	QP	Hor



Project: LGT23D025	Test Engineer: Dylan.shi
EUT: Bluetooth Headphones	Temperature: 28.3°C
M/N: HS-BN928	Humidity: 55%RH
Test Voltage: Battery	Test Data: 2023-04-12
Test Mode: Bluetooth	
Note:	



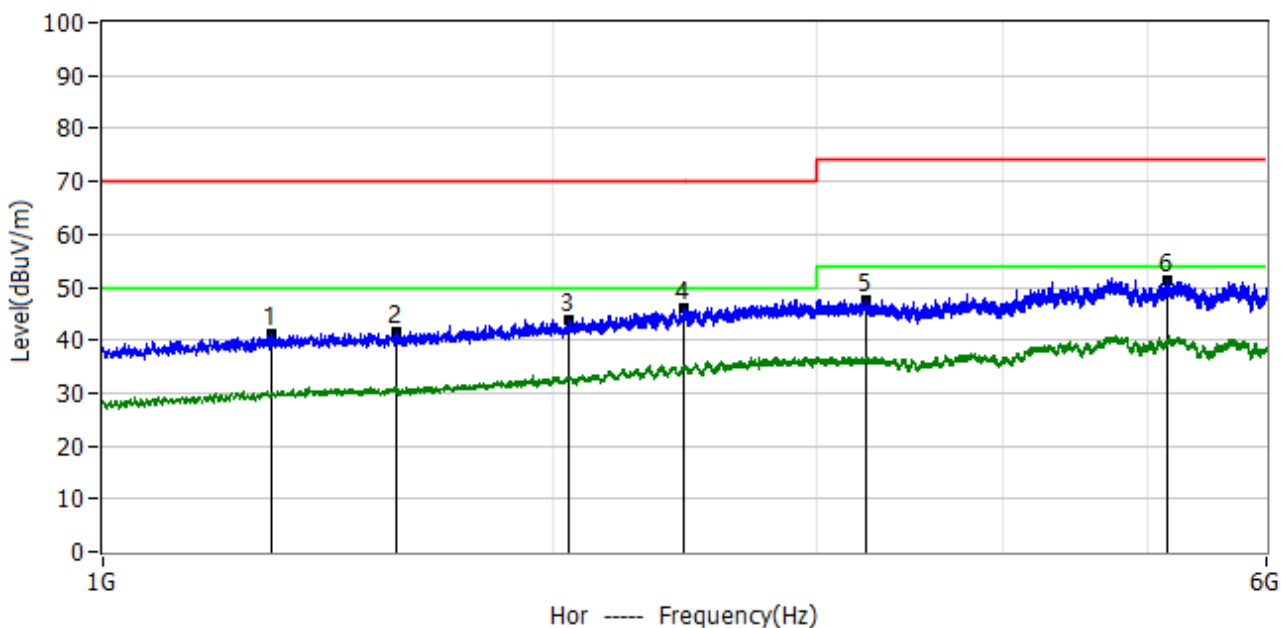
No.	Frequency	Reading dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Margin dB	Detector	Polar
1*	39.700MHz	3.83	19.33	23.16	40.00	-16.84	QP	Ver
2*	52.674MHz	3.74	19.17	22.91	40.00	-17.09	QP	Ver
3*	155.615MHz	4.28	19.91	24.19	40.00	-15.81	QP	Ver
4*	502.875MHz	3.89	24.92	28.81	47.00	-18.19	QP	Ver
5*	835.949MHz	5.72	32.01	37.73	47.00	-9.27	QP	Ver
6*	989.451MHz	5.32	34.52	39.84	47.00	-7.16	QP	Ver





### 3.2.7 TEST RESULT (1000 - 6000MHz)

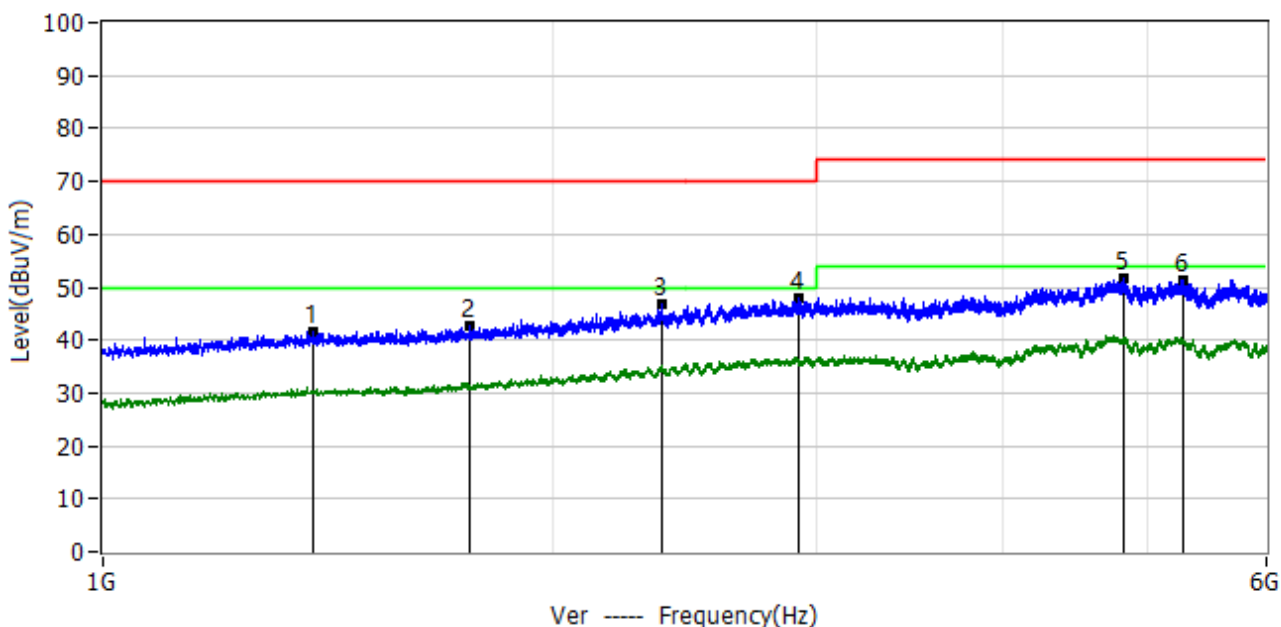
Project: LGT23D025	Test Engineer: Dylan.shi
EUT: Bluetooth Headphones	Temperature: 22.5°C
M/N: HS-BN928	Humidity: 56%RH
Test Voltage: Battery	Test Data: 2023-04-12
Test Mode: Bluetooth	
Note:	



No.	Frequency	Reading dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Margin dB	Detector	Polar
1*	1.298GHz	63.33	-22.19	41.14	70.00	-28.86	PK	Hor
2*	1.569GHz	62.07	-20.38	41.69	70.00	-28.31	PK	Hor
3*	2.046GHz	59.57	-15.74	43.83	70.00	-26.17	PK	Hor
4*	2.444GHz	57.49	-11.58	45.91	70.00	-24.09	PK	Hor
5*	3.236GHz	56.12	-8.42	47.70	74.00	-26.30	PK	Hor
6*	5.144GHz	57.78	-6.60	51.18	74.00	-22.82	PK	Hor



Project: LGT23D025	Test Engineer: Dylan.shi
EUT: Bluetooth Headphones	Temperature: 22.5°C
M/N: HS-BN928	Humidity: 56%RH
Test Voltage: Battery	Test Data: 2023-04-12
Test Mode: Bluetooth	
Note:	



No.	Frequency	Reading dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Margin dB	Detector	Polar
1*	1.380GHz	63.21	-21.54	41.67	70.00	-28.33	PK	Ver
2*	1.757GHz	61.25	-18.67	42.58	70.00	-27.42	PK	Ver
3*	2.362GHz	59.08	-12.43	46.65	70.00	-23.35	PK	Ver
4*	2.916GHz	56.83	-8.79	48.04	70.00	-21.96	PK	Ver
5*	4.813GHz	57.53	-6.00	51.53	74.00	-22.47	PK	Ver
6*	5.281GHz	58.53	-7.04	51.49	74.00	-22.51	PK	Ver



### 3.3 HARMONICS CURRENT

#### 3.3.1 LIMITS OF THE HARMONICS CURRENT

IEC 555-2					
Table - I			Table - II		
Equipment Category	Harmonic Order n	Max. Permissible Harmonic Current (in Amperes)	Equipment Category	Harmonic Order n	Max. Permissible Harmonic Current (in Amperes)
Non Portable Tools or TV Receivers	Odd Harmonics		TV Receivers	Odd Harmonics	
	3	2.30		3	0.80
	5	1.14		5	0.60
	7	0.77		7	0.45
	9	0.40		9	0.30
	11	0.33		11	0.17
	13	0.21		13	0.12
	15 ≤ n ≤ 39	0.15 · 15/n		15 ≤ n ≤ 39	0.10 · 15/n
	Even Harmonics			Even Harmonics	
	2	1.08		2	0.30
4	0.43	4	0.15		
8	0.30				
8 ≤ n ≤ 40	0.23 · 8/n	DC	0.05		

EN 61000-3-2/IEC 61000-3-2					
Equipment Category	Max. Permissible Harmonic Current (in Amperes)	Equipment Category	Harmonic Order n	Max. Permissible Harmonic Current (in A)	Max. Permissible Harmonic Current (mA/w)
Class A	Same as Limits Specified in 4-2.1, Table - I, but only odd harmonics required	Class D	3	2.30	3.4
			5	1.14	1.9
			7	0.77	1.0
			9	0.40	0.5
			11	0.33	0.35
			13 ≤ n ≤ 39	see Table I	3.85/n
only odd harmonics required					

#### 3.3.2 TEST PROCEDURE

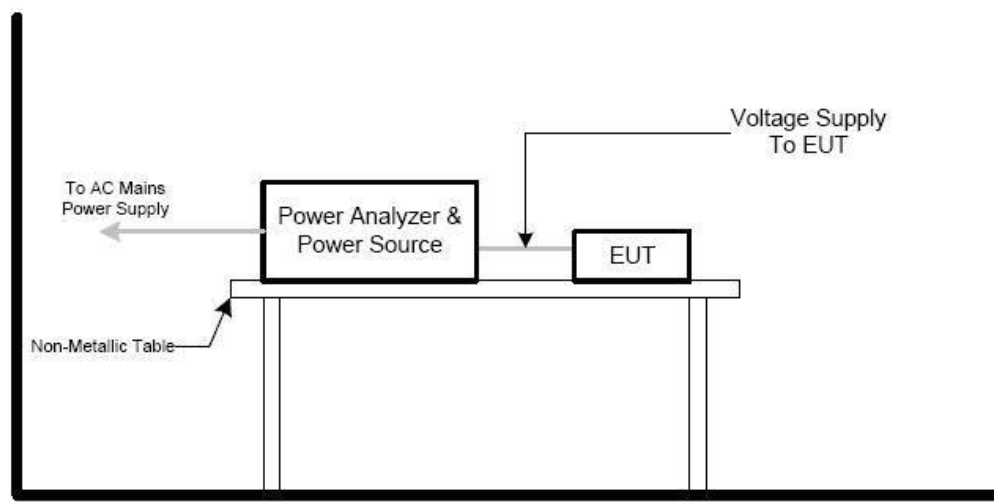
- The EUT was placed on the top of a wooden table 0.8 meter above the ground and operated to produce the maximum harmonic components under normal operating conditions.
- The classification of EUT is according to section 5 of EN IEC 61000-3-2. The EUT is classified as follows:
  - Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.
  - Class B: Portable tools. Portable tools; Arc welding equipment which is not professional equipment.
  - Class C: Lighting equipment.
  - Class D: Equipment having a specified power less than or equal to 600W of the following types: Personal computers and personal computer monitors and television receivers.
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



### 3.3.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** described unless otherwise a special operating condition is specified in the following during the testing.

### 3.3.4 TEST SETUP



### 3.3.5 TEST RESULTS

*N/A. This part is applicable to the power input terminals of equipment intended to be connected to 220/380 V, 230/400 V and 240/415 V systems operating at 50 Hz or 60 Hz. Requirements and limits for other cases are not yet specified.*



### 3.4 VOLTAGE FLUCTUATION AND FLICKERS

#### 3.4.1 LIMITS OF THE VOLTAGE FLUCTUATION AND FLICKERS

Tests	Measurement Value		Descriptions
	IEC555-3	IEC/EN 61000-3-3	
$P_{st}$	$\leq 1.0$ , $T_p= 10$ min.	$\leq 1.0$ , $T_p= 10$ min.	Short Term Flicker Indicator
$P_{lt}$	N/A	$\leq 0.65$ , $T_p=2$ hr.	Long Term Flicker Indicator
$T_{dt(s)}$	$\leq 3\%$	$\leq 3.3\%$	Relative Steady-State V-Chang
$d_{max}$ (%)	$\leq 4\%$	$\leq 4\%$	Maximum Relative V-Chang
$d_c$ (%)	N/A	$\leq 3.3\%$ for $> 500$ ms	Relative V-change Characteristic

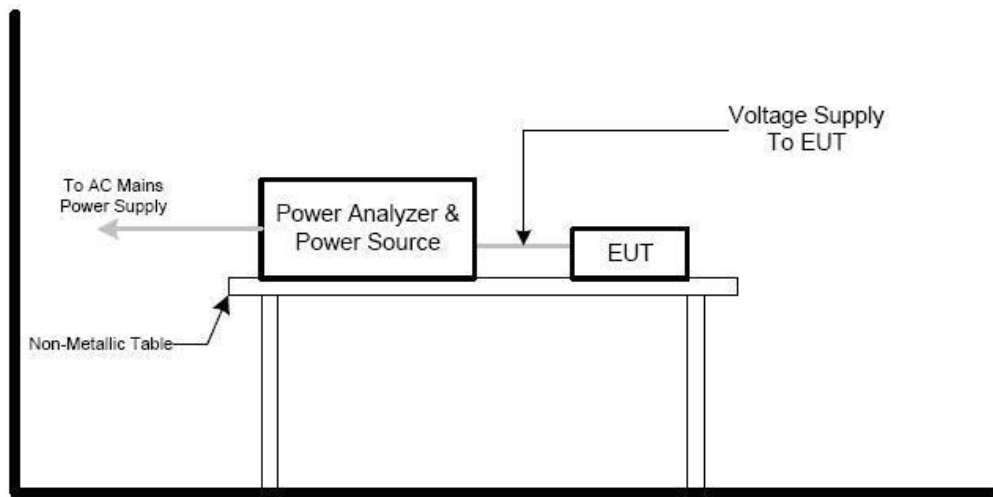
#### 3.4.2 TEST PROCEDURE

- a. Fluctuation and Flickers Test:  
Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 5.0/6.0 of IEC555-3 and/or Clause 6.0/4.0 of IEC/EN 61000-3-3 depend on which standard adopted for compliance measurement.
- b. All types of voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

#### 3.4.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 described unless otherwise a special operating condition is specified in the following during the testing.

#### 3.4.4 TEST SETUP



#### 3.4.5 TEST RESULTS

N/A. This part is applicable to electrical and electronic equipment having an input current equal to or less than 16 A per phase, intended to be connected to public low-voltage distribution systems of between 220 V and 250 V line to neutral at 50 Hz, and not subject to conditional connection.



## 4. EMC IMMUNITY TEST

### 4.1 GENERAL PERFORMANCE CRITERIA

#### 4.1.1 PERFORMANCE CRITERIA (ETSI EN 301 489-17)

According to **ETSI EN 301 489-17** standard, the general performance criteria are as follows:

Criteria	During the test	After the test
A	Shall operate as intended. (see note 1). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended Shall be no degradation of performance (see note 2) Shall be no loss of function Shall be no loss of stored data or user programmable functions
B	May show loss of function (one or more) May show degradation of performance (see note 1) No unintentional transmissions	Functions shall be self-recoverable Shall operate as intended after recovering Shall be no degradation of performance (see note 2) Shall be no loss of stored data or user programmable functions
C	May be loss of function (one or more)	Functions shall be recoverable by the operator Shall operate as intended after recovering Shall be no degradation of performance (see note 2)

NOTE 1: Operate as intended during the test allows a level of degradation not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some case the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some case the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 3: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some case the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.



### **Performance for TT**

The performance criteria B shall apply, except for voltage dips of 100ms and voltage interruptions of 5 000ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (N/ACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

### **Performance for TR**

The performance criteria B shall apply, except for voltage dips of 100ms and voltage interruptions of 5 000ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test In systems using acknowledgement signals, it is recognized that an ACK or N/ACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

### **Performance for CT**

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an Acknowledgement (ACK) or Not Acknowledgement (N/ACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

### **Performance for CR**

The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test In systems using acknowledgement signals, it is recognized that an ACK or N/ACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### **4.1.2 GENERAL PERFORMANCE CRITERIA TEST SETUP**

The EUT tested system was configured as the statements of **2.2** or **2.3** unless otherwise a special operating condition is specified in the following during the testing.



## 4.2 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

### 4.2.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance:	B
Discharge Voltage:	Air Discharge: 2KV/4KV/8KV (Direct) Contact Discharge: 4KV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: at least 10 times on each point Contact Discharge: at least 10 times on each point
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

### 4.2.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manners:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation  
The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.

The time interval between two successive single discharges was at least 1 second.

The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meter from the EUT.

Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.

Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.

Vertical Coupling Plane (VCP):

The coupling plane of dimensions 0.5m x 0.5m, is placed parallel to and positioned at a distance 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

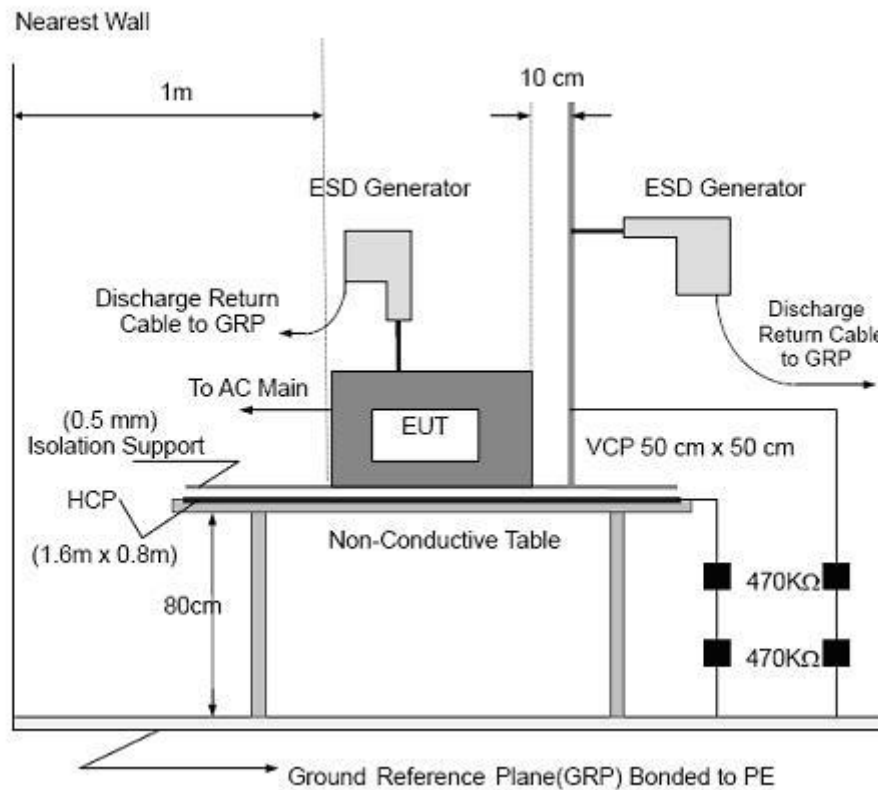
The four faces of the EUT will be performed with electrostatic discharge.

- b. Air discharges at insulation surfaces of the EUT.  
It was at least ten single discharges with positive and negative at the same selected point.





### 4.2.3 TEST SETUP



Note:

#### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meter high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940kΩ total impedance. The equipment under test was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of 0.8-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.



#### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP was consisted of a sheet of aluminum that is at least 0.25mm thick, and extended at least 0.5 meter from the EUT on all sides.



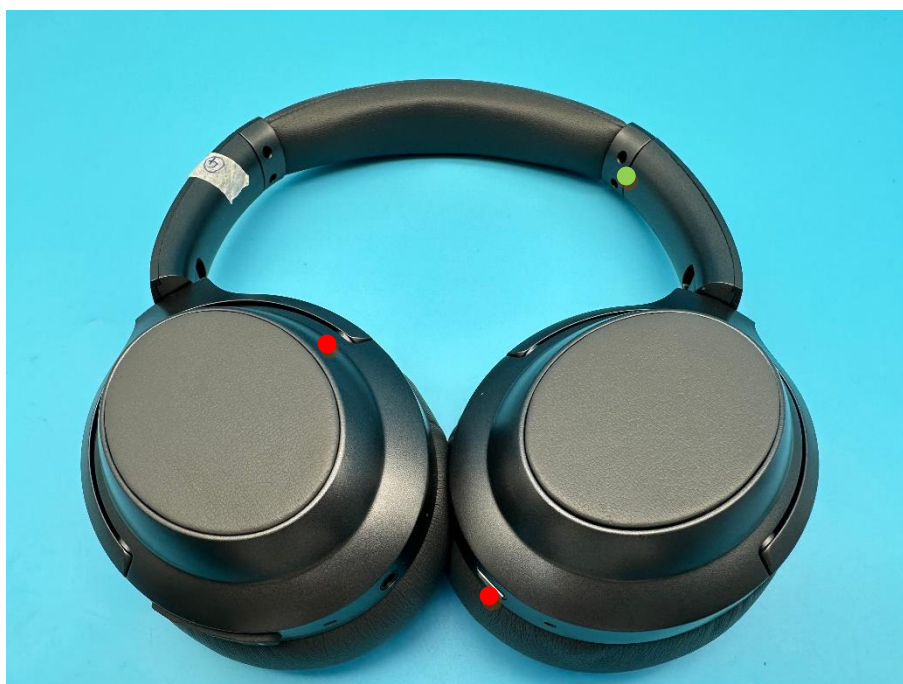
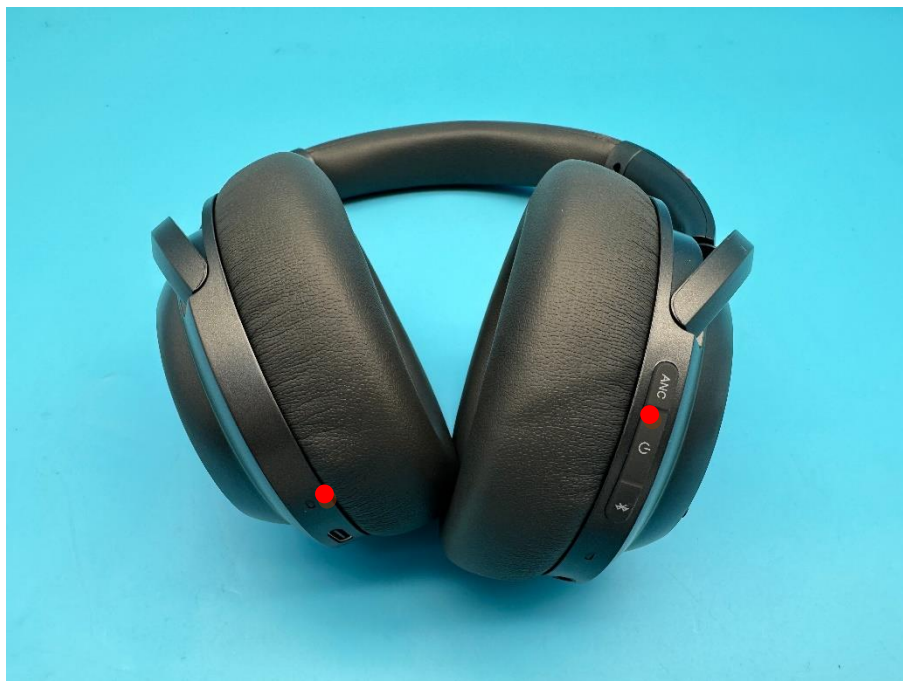
#### 4.2.4 TEST RESULT

Temperature:	24.4°C	Relative Humidity:	58%
Pressure:	1017.8hPa	Test Date:	2023.04.14

Discharge times	Contact discharge: minimum 10 times (+/--respectively) at each point Air discharge: minimum 10 times (+/- respectively) at each point					
Discharge Level/KV	Polarity	Test Points	Contact Discharge	Air Discharge	Criterion	Test Result
2,4	+/-	HCP/VCP	A	NA	B	Pass
2,4,	+/-	Green Dot	A	NA	B	Pass
2,4,8	+/-	Red Dot	NA	A	B	Pass
Note 1: EUT operate as intended during the test Normal performance within limits specified by the manufacturer, request or purchaser						
Note 2:  Red Dot_Air Discharged,  Green Dot_Contact Discharged						



### The Photo for Discharge Points of EUT





## 4.3 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

### 4.3.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-3
Required Performance:	A
Frequency Range:	80 MHz - 6000 MHz
Field Strength:	3 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Dwell Time:	$1.5 \times 10^{-3}$ decade/s

### 4.3.2 TEST PROCEDURE

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

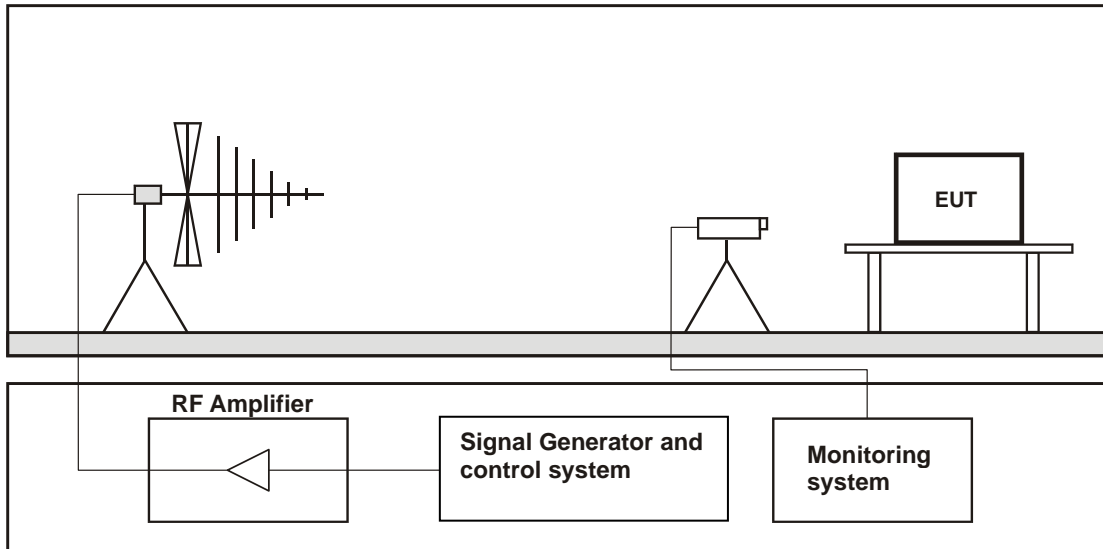
The testing distance from antenna to the EUT was 3 meters.

The other conditions required in the following manners:

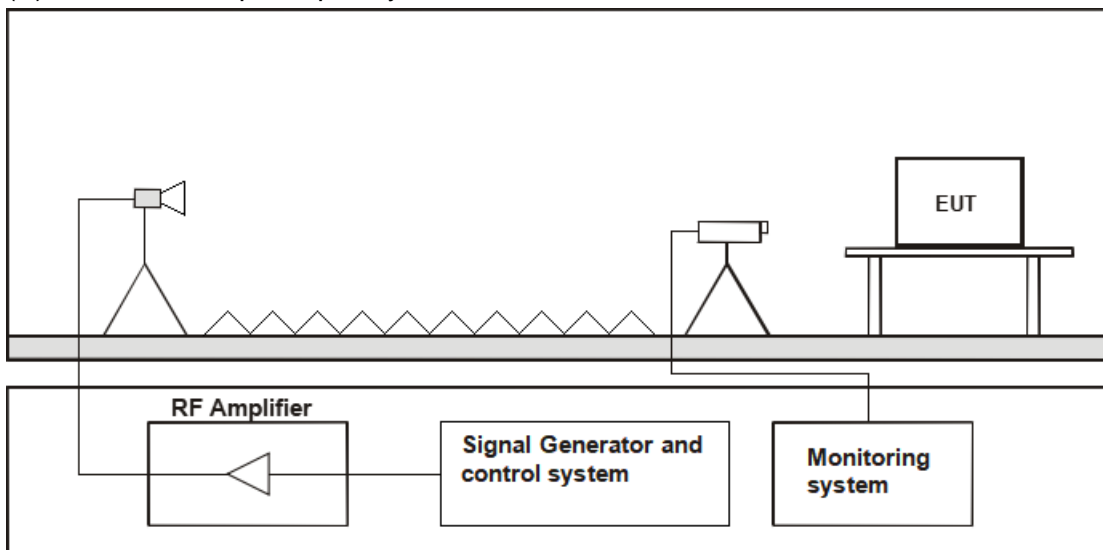
- a. The frequency range is swept from 80 MHz to 6000 MHz with the signal 80% amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed  $1.5 \times 10^{-3}$  decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- b. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- c. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

### 4.3.3 TEST SETUP

#### (A) RS Test Set-Up Frequency Below 1GHz



#### (B) RS Test Set-Up Frequency Above 1GHz



Note:

#### TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meter in height. The system under test was connected to the power and signal wire according to the relevant installation instructions.

#### FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meter in height. The system under test was connected to the power and signal wire according to the relevant installation instructions.



#### 4.3.4 TEST RESULTS

Temperature:	24.4°C	Relative Humidity:	58%
Test Power:	AC 230V/50Hz	Test Date:	2023.04.14

Test Level	3 V r.m.s. (unmodulated) 1 kHz, 80 % AM, sine wave		Criterion	A
Frequency Range(MHz)	Antenna polarity	Modulation	EUT position	Result
80MHz-1000MHz	Horizontal/ Vertical	1KHz, 80% AM	Front	PASS
			Rear	PASS
			Left	PASS
			Right	PASS
1000MHz-6000MHz	Horizontal/ Vertical	1KHz, 80% AM	Front	PASS
			Rear	PASS
			Left	PASS
			Right	PASS

Note: EUT operate as intended during the test Normal performance within limits specified by the manufacturer, request or purchaser

**Note:**

- 1) N/A - denotes test is not applicable in this test report.
- 2) Criteria A: There was no change operated with initial operating during the test.
- 3) Criteria B: The EUT function loss during the test, but self-recoverable after the test.
- 4) Criteria C: The system shut down during the test.



## 4.4 ELECTRICAL FAST TRANSIENT (EFT)

### 4.4.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-4
Required Performance:	B
Test Voltage:	Power Line: 1 KV Signal/Control Line: 0.5 KV
Polarity:	Positive & Negative
Impulse Frequency:	5kHz
Impulse Wave shape:	5/50ns
Burst Duration:	15ms
Burst Period:	300ms
Test Duration:	Not less than 1 min

### 4.4.2 TEST PROCEDURE

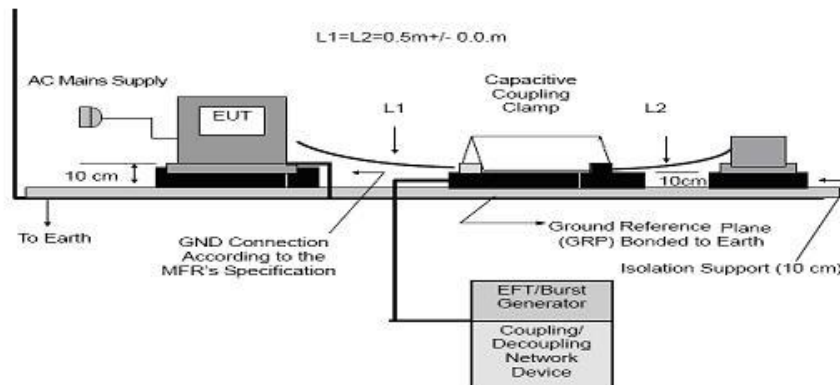
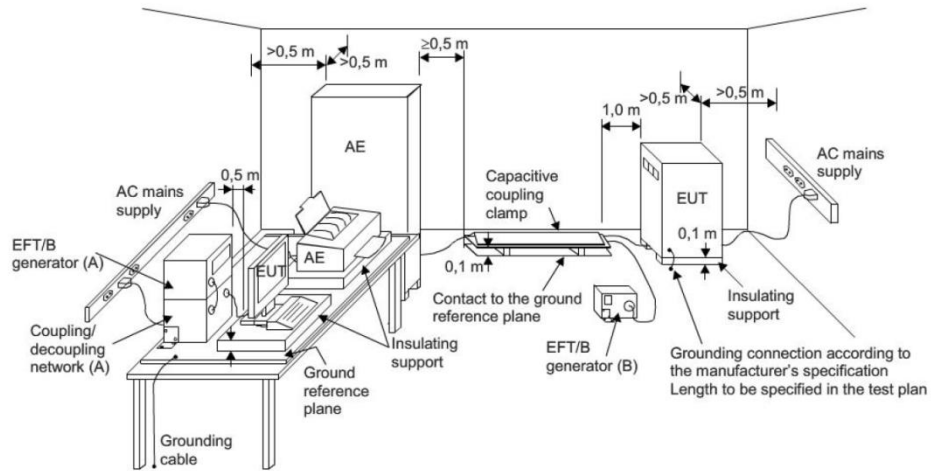
The EUT and support equipment, are placed on a table that is 0.8 meter & 0.1 meter above a metal ground plane measured 1m\*1m min.

The ground reference plane shall be a metallic sheet (copper or aluminum) of 0.25 mm minimum thickness; other metallic materials may be used, but they shall have at least 0.65 mm minimum thickness.

The other conditions required in the following manners:

- a. The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- b. Both positive and negative polarity discharges were applied.
- c. The duration time of each test sequential was 1 minutes.

### 4.4.3 TEST SETUP







Note:

#### TABLE-TOP EQUIPMENT

- a. Table-top equipment and equipment normally mounted on ceilings or walls as well as built-in equipment shall be tested with the EUT located  $(0.1 \pm 0.01)$  m above the ground reference plane.
- b. Testing of large table-top equipment or multiple systems can be performed on the floor; maintaining the same distances as for the test setup of table-top equipment.
- c. The test generator and the coupling/decoupling network shall be bonded to the ground reference plane.
- d. The ground reference plane shall be a metallic sheet (copper or aluminum) of 0.25mm minimum thickness; other metallic materials may be used, but they shall have at least 0.65 mm minimum thickness.
- e. The minimum size of the ground reference plane is 0.8m x 1m. The actual size depends on the dimension of the EUT.
- f. The ground reference plane shall project beyond the EUT by at least 0.1m on all sides.
- g. The ground reference plane shall be connected to the earth (PE) for safety reasons.
- h. The EUT shall be arranged and connected to satisfy its functional requirements according to the equipment installation specifications.
- i. The minimum distance between the EUT and all other conductive structures (including the generator, AE and the walls of a shielded room), except the ground reference plane, shall be more than 0.5m.
- j. All cables to the EUT shall be placed on the insulation support 0.1m above the ground reference plane. Cables not subject to electrical fast transients shall be routed as far as possible from the cable under test to minimize the coupling between the cables.
- k. The EUT shall be connected to the earth system in accordance with the manufacturer's installation specifications; no additional earth connections are allowed.
- l. The connection impedance of the coupling/decoupling network earth cables to the ground reference plane and all connectors shall provide a low inductance.
- m. Either a direct coupling network or a capacitive clamp shall be used for the application of the test voltages. The test voltages shall be coupled to all of the EUT ports in turn including those between two units of equipment involved in the test, unless the length of the interconnecting cable makes it impossible to test.

#### FLOOR-STANDING EQUIPMENT

When using the coupling clamp, the minimum distance between the coupling plates and all other conductive surfaces (including the generator), except the ground reference plane beneath the coupling clamp and beneath the EUT, shall be at least 0.5m.

The distance between any coupling devices and the EUT shall be  $(0.5 - 0/+0.1)$  m for tabletop equipment testing, and  $(1.0 \pm 0.1)$  m for floor standing equipment, unless otherwise specified in product standards. When it is not physically possible to apply the distances mentioned above, other distances can be used and shall be recorded in the test report.

The cable between the EUT and the coupling device, if detachable, shall be as short as possible to comply with the requirements of this clause. If the manufacturer provides a cable exceeding the distance between the coupling device and the point of only of the EUT, the excess length of this cable shall be bundled and situated at a distance of 0.1m above the ground reference plane. When a capacitive clamp is used as a coupling device, the excess cable length shall be bundled at the AE side. Parts of the EUT with interconnecting cables of a length less than 3m, which are not tested, shall be placed on the insulating support. The parts of the EUT shall have a distance of 0.5m between them. Excess cable length shall be bundled.

#### 4.4.4 TEST RESULTS

N/A



## 4.5 SURGE TESTING

### 4.5.1 TEST SPECIFICATION

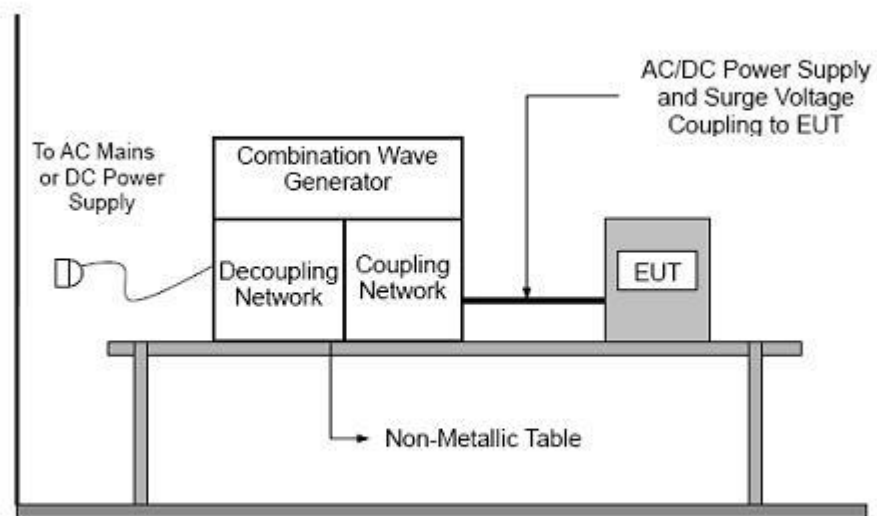
Basic Standard:	IEC/EN 61000-4-5
Required Performance:	B
Wave-Shape:	Combination Wave 1.2/50us Open Circuit Voltage
Test Voltage:	Power line ~ line to line: 1 KV line to ground: 2KV Telecommunication line: 1 KV
Surge Input/Output:	L-N, L-PE, N-PE
Generator Source:	(L-N)2 ohm between networks
Impedance:	(L-PE, N-PE)12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	90°/270°
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

### 4.5.2 TEST PROCEDURE

- a. For EUT power supply:  
The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meter in length (or shorter).
- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:  
The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meter in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection/telecommunication lines of EUT.  
The surge was applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrester was not specified. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meter in length.



### 4.5.3 TEST SETUP



### 4.5.4 TEST RESULTS

N/A



## 4.6 CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

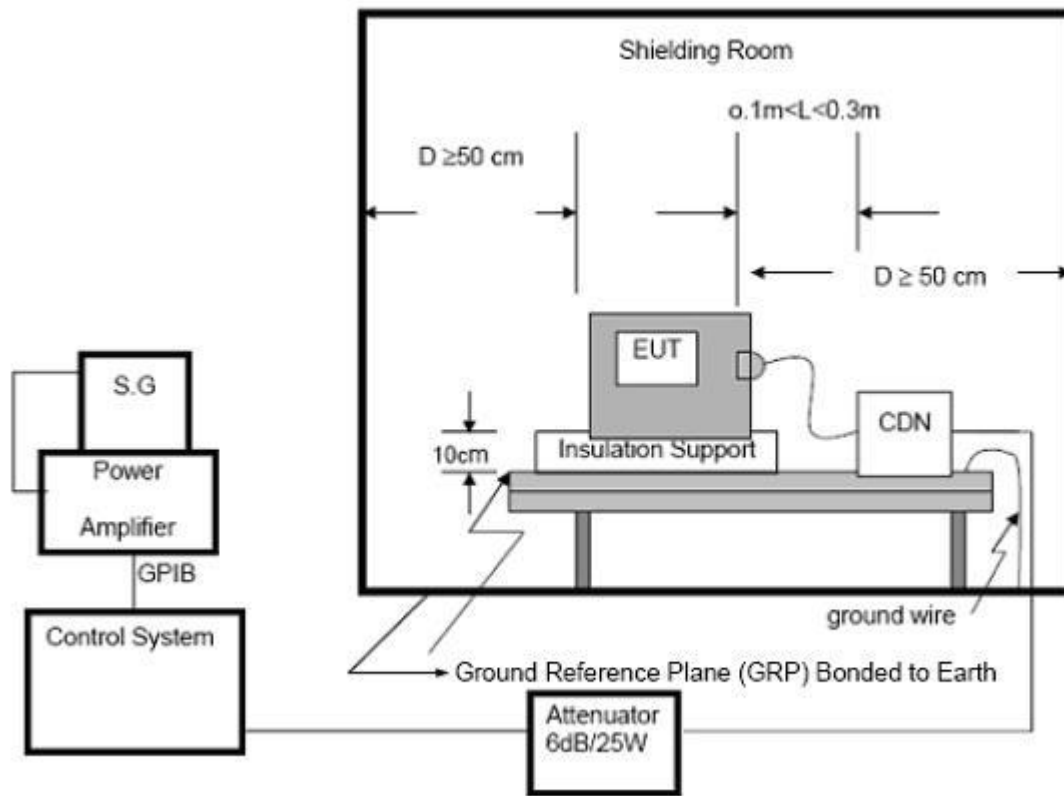
### 4.6.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-6
Required Performance:	A
Frequency Range:	0.15 MHz - 80 MHz
Field Strength:	3Vr.m.s.
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Dwell Time:	1.5x 10 <sup>-3</sup> decade/s

### 4.6.2 TEST PROCEDURE

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50Ω, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1% of the preceding frequency value.
- e. The dwell time of the amplitude modulated carrier at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0.5 s. The sensitive frequencies (e.g. clock frequencies) shall be analyzed separately.
- f. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

#### 4.6.3 TEST SETUP



NOTE:

#### FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meter height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meter and 0.3 meter from the projected geometry of the EUT on the ground reference plane.

#### 4.6.4 TEST RESULTS

N/A



## 4.7 VOLTAGE INTERRUPTION/DIPS TESTING (DIPS)

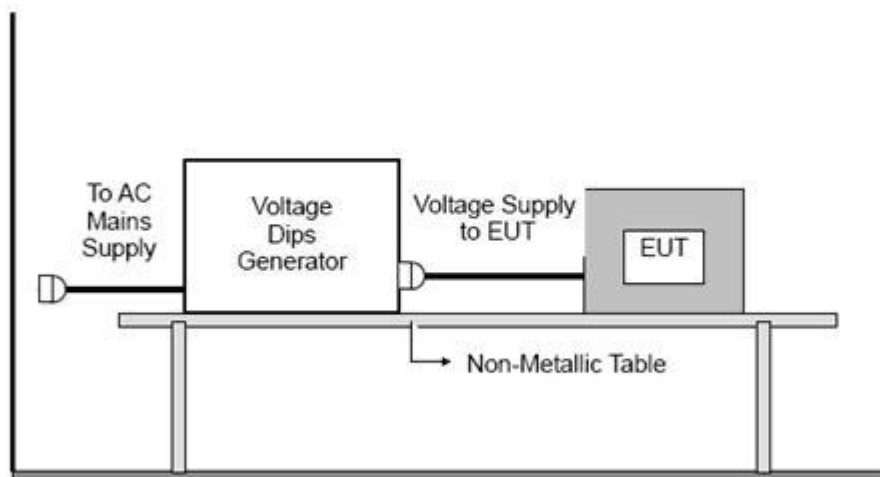
### 4.7.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-11
Required Performance:	B (For 100% Voltage Dips, 0.5 Cycle) B (For 100% Voltage Dips, 1 Cycle) C (For 30% Voltage Dips, 25 Cycles) C (For 100% Voltage Interruptions, 250 Cycles)
Test Duration Time:	Minimum 3 test events in sequence
Interval between Event:	Minimum 10 seconds
Phase Angle:	0°/45°/90°/135°/180°/225°/270°/315°/360°
Test Cycle:	3 times

### 4.7.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

### 4.7.3 TEST SETUP



### 4.7.4 TEST RESULTS

N/A

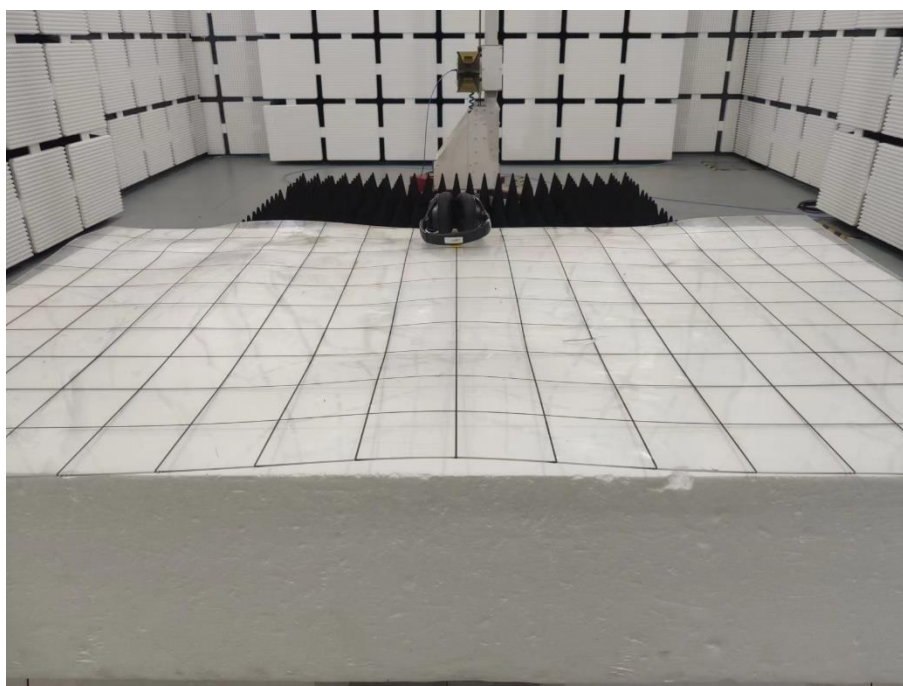


## APPENDIX I - TEST SETUP

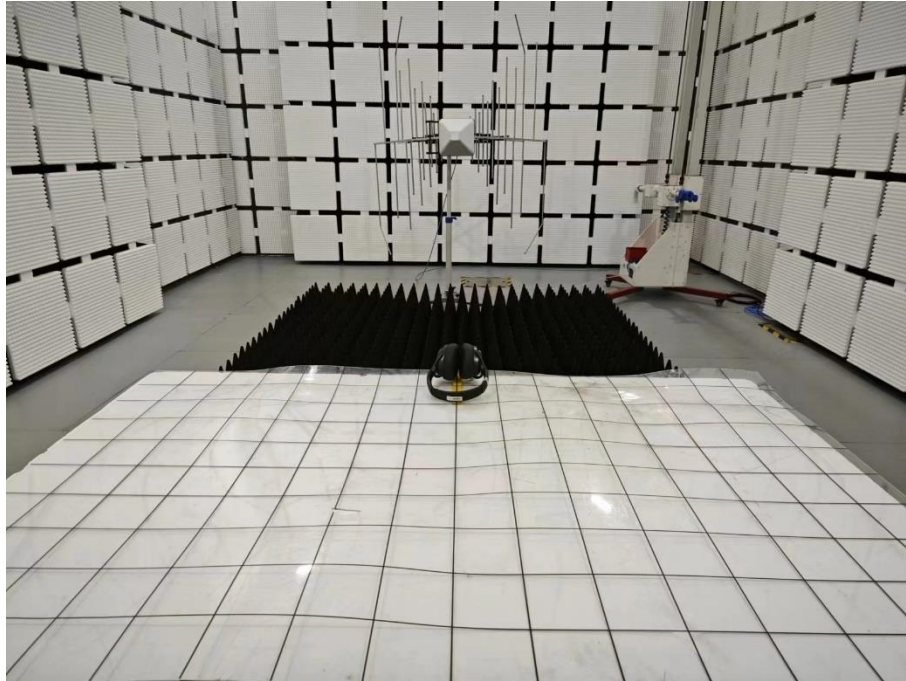
**Set-up for Radiated Emission (RE), Below 1GHz**



**Set-up for Radiated Emission (RE), Above 1GHz**



### Set-up for Radio Frequency Electromagnetic Fields (RS)



### Set-up for Electrostatic Discharges (ESD)



※※※※※END OF THE REPORT※※※※※